[TS14T5]

Nanometric Metrology and Computation 4

Date & Time	July 4(Thu.), 2024 / 15:40-18:25
Place	Room 209B
Session Chair(s)	Hyoung Jeen (Pusan Nat'l Univ.)

TS14T5 | 1 *Invited

15:40-16:10

Nanoscale Temperature Mapping for Operating Devices with Reflection Electron Elastic Energy Thermometry (REEET)

Menglong Hao^{1,3}, Qiye Zheng^{2,3,4}, Ziwen Zhang^{1,3}, Yicong Qiu², Yuhang Cai³, Xing Xiang², Saad Safiullah², Yanguang Zhou², Junqiao Wu^{3,4}, and Chris Dames^{3,4}

(1Southeast University, 2HKUST, 3University of California, 4Lawrence Berkeley National Laboratory)

TS14T5_O_2 16:10-16:25

Comparison DUV to NUV in Atom Probe Tomography based on Different Materials

Chang-Gi Lee, Ijun Rho, and Se-Ho Kim

(Korea University)

TS14T5_O_3 16:25-16:40

Three-Dimensional Polar Topology in Ferroelectric Nanoparticles

Yongsoo Yang¹, Chaehwa Jeong¹, Juhyeok Lee¹, Hyesung Jo¹, Jaewhan Oh¹, Hionsuck Baik², Kyoung-June Go³, Junwoo Son³, Si-Young Choi³, Sergey Prosandeev⁴, and Laurent Bellaiche⁴

(1KAIST, 2KBSI, 3POSTECH, 4University of Arkansas)

TS14T5_I_4 *Invited

16:40-17:10

Exploring Quasi-Particle Transport in Polymers

Taeyong Kim

(Seoul National University)

17:10-17:25 TS14T5_O_5

Enhancing Li Kinetics in Truncated Octahedral-Shaped LiNi_{0.5}Mn_{1.5}O₄ Cathode via Superior LiNbO₃ Coating on {111} Facets

Jeong-Min Kim¹, Min Seuk Kim², Si Jin Sung², Ji Seul Gi², Sun Sook Lee², Sungho Choi², and Si-Young Choi¹

(1POSTECH, 2KRICT)

TS14T5_O_6 17:25-17:40

Site Selectivity of Single Dopant in High-Nickel Cathodes for Lithium-Ion Batteries

So-Yeon Kim¹, Yu-Jeong Yang¹, Eun Gyu Lee², Min-Su Kim¹, Kyoung-June Go¹, Minseuk Kim², Gi-Yeop Kim¹, Sungho Choi², and Si-Young Choi^{1,3}

(1POSTECH, 2KRICT, 3IBS)

TS14T5_O_7 17:40-17:55

Nanostructured Reference Materials for Nano Measurement by SEM and AFM

Kyung Joong Kim

(Kims Reference Corp.)

TS14T5_I_8 *Invited 17:55-18:25

Exploration of Nanoscale Functionalities of Complex Oxides via Scanning Probe Microscopy

Yooun Heo

(Inha University)

NANO KOREA 2024 Symposium